

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination ABE ET AL.	
		Examiner Crystal I. Leach	Art Unit 3737	Page 1 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,690,961	02-2004	Kaufman et al.	600/410
*	B	US-6,222,365	04-2001	Taniguchi et al.	324/309
*	C	US-6,459,264	10-2002	Fain et al.	324/307
*	D	US-6,577,127	06-2003	Harvey et al.	324/307
*	E	US-5,713,358	02-1998	Mistretta et al.	600/420
*	F	US-6,946,836	09-2005	Kuhara, Shigehide	324/307
*	G	US-5,045,791	09-1991	Yamamoto et al.	324/309
*	H	US-6,639,211	10-2003	Anand et al.	250/282
*	I	US-5,827,187	10-1998	Wang et al.	600/419
*	J	US-4,830,012	05-1989	Riederer, Stephen J.	600/410
*	K	US-6,195,579	02-2001	Carroll et al.	600/420
*	L	US-6,603,992	08-2003	Debbins et al.	600/420
*	M	US-5,798,642	08-1998	Watanabe, Shigeru	324/307

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 200204970 A1	01-2002	World Intellect	GERAATS et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination ABE ET AL.	
		Examiner Crystal I. Leach	Art Unit 3737	Page 2 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,897,496	04-1999	Watanabe, Shigeru	600/413
*	B	US-6,044,290	03-2000	Vigen et al.	600/419
*	C	US-6,097,185	08-2000	Watanabe et al.	324/309
*	D	US-5,474,067	12-1995	Laub, Gerhard	600/413
*	E	US-5,485,086	01-1996	Meyer et al.	324/307
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.